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CAPACITOR FILTERS, PI-TYPE, FEEDTHROUGH,

ELECTROMAGNETIC INTERFERENCE

SUPPRESSION, NON-HERMETICALLY SEALED,

BASED ON TYPE SFP060

ESCC Detail Specification No. 3008/030

ISSUE 1 October 2002



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space components coordination group

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DOCUMENTATION CHANGE NOTICE

Rev. Letter	Rev. Date	Reference	CHANGE Item	Approved DCR No.
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1. <u>GENERAL</u>

1.1 <u>SCOPE</u>

This specification details the ratings, physical and electrical characteristics, test and inspection data for a Capacitor Filter, Pi-Type, Feedthrough, Electromagnetic Interference Suppression, Non-Hermetically Sealed, based on Type SFP060. It shall be read in conjunction with ESA/SCC Generic Specification No. 3008, the requirements of which are supplemented herein.

1.2 COMPONENT TYPE VARIANTS

Variants of the basic type capacitor filters specified herein, which are also covered by this specification are given in Table 1(a).

1.3 MAXIMUM RATINGS

The maximum ratings, which shall not be exceeded at any time during use or storage, applicable to the capacitor filters specified herein, are as scheduled in Table 1(b).

1.4 PARAMETER DERATING INFORMATION

The parameter derating information applicable to the capacitor filters specified herein, is shown in Figure 1.

1.5 PHYSICAL DIMENSIONS

The physical dimensions of the capacitor filters specified herein, are shown in Figure 2.

1.6 FUNCTIONAL DIAGRAM

The functional diagram, showing lead identification, of the capacitor filters specified herein, is shown in Figure 3.

2. APPLICABLE DOCUMENTS

The following documents form part of this specification and shall be read in conjunction with it:

- (a) ESA/SCC Generic Specification No. 3008 for Capacitors and Capacitor Filters, Feedthrough.
- (b) MIL-STD-202, Test Methods for Electronic and Electrical Component Parts.

3. TERMS, DEFINITIONS, ABBREVIATIONS, SYMBOLS AND UNITS

For the purpose of this specification, the terms, definitions, abbreviations, symbols and units specified in ESA/SCC Basic Specification No. 21300 shall apply. In addition, the following abbreviations are used:-

V_T = Test Voltage.

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TABLE 1(a) - TYPE VARIANTS

(11) Weight		(g)	4.0	3.0	4.0	4.0	3.0	4.0	4.0
(10) Case Size (Note 1)			1	2	3	1	2	1	e
(9) tpplied	1.0GHz		70 / 70	65 / 65	70 / 70	75 / 75	70 / 70	70 / 70	70 / 70
) (dB) th current a	500MHz		68 / 55	65 / 65	68 / 65	75 / 75	70 / 70	70 / 70	60 / 60
Insertion Loss (I _L) (dB) With no current applied / With current applied	100MHz		65 / 55	65 / 60	65 / 55	75 / 75	60 / 55	70 / 70	45 / 25
Inserti o current al	50MHz		50 / 25	50 / 35	50 / 30	70 / 70	45 / 40	70 / 70	30 / 20
	10MHz		14 / 14	20 / 20	20 / 20	60 / 35	18 / 15	60 / 35	4.0 / -
(8) Capacitance C		(pF)	7 520	8 960	8 000	89 600	16 000	89 600	2 400
(7) Rated Current I _R		(10	10	10	10	10	10	10
(6) d.c. Resistance Rs		(mΩ)	20	15	15	15	15	15	15
(5) Voltage Drop V _{dr}		S	0.20	0.15	0.15	0.15	0.15	0.15	0.15
(4) Voltage Proof VP		ŝ	750	500	500	250	500	125	700
(3) Insulation Resistance Ri (GΩ)	(b) + 125°C		1.0	1.0	1.0	0.5	0.5	0.5	1.0
Insul Resis Ri ((a) - 55°C/	+ 85°C	10	10	10	5.0	5.0	5.0	õ
(2) Rated Voltage U _R (V)	(b) + 85°C/	+125°C	300	100	100	70	100	35	200
Rated > U	(a) - 55°C/	+ 85°C	500	200	200	100	200	50	350
(1) Variant (Note 1)			01, 08, 15, 22	02, 09, 16, 23	03, 10, 17, 24	04, 11, 18, 25	05, 12, 19, 26	06, 13, 20, 27	07, 14, 21, 28

NOTES 1. See the Table below and Figure 2 for physical characteristics.

VARIANT	CASE THREAD E	LOCK WASHER	INPUT TERMINAL
01 to 07	1 : M6×0.75	Fan	Straight
08 to 14	1 : M6×0.75	Fan	Button
15 to 21	U : 12-32 UNC	Tooth	Straight
22 to 28	U : 12-32 UNC	Tooth	Button

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TABLE 1(b) - MAXIMUM RATINGS

No.	Characteristic	Symbol	Maximum Ratings	Unit	Remarks
1	Rated d.c. Voltage	U _R	See Table 1(a) Column 2	V	Notes 1 and 2
2	Voltage Drop	V _{dr}	See Table 1(a) Column 5	V	
3	d.c. Resistance	Rs	See Table 1(a) Column 6	mΩ	
4	Rated Current	I _R	10	А	Note 3
5	Torque	T _{qe}	0.8	Nm	
6	Operating Temperature Range	Т _{ор}	-55 to +125	°C	T _{amb}
7	Storage Temperature Range	T _{stg}	- 55 to + 125	°C	
8	Soldering Temperature	T _{sol}	+ 260	°C	Note 4

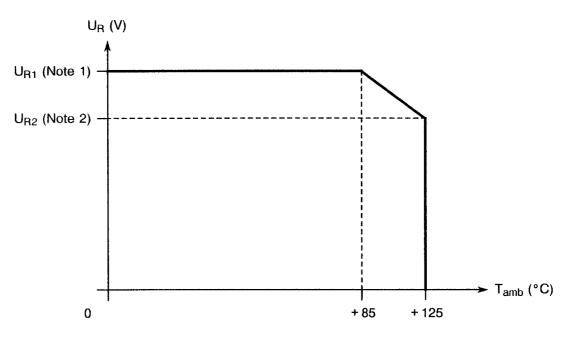
NOTES

1. At $T_{amb} \le +85^{\circ}$ C. For derating at $T_{amb} > +85^{\circ}$ C, see Figure 1. 2. The addition of d.c. applied voltage and ripple voltage shall never exceed the rated d.c. voltage.

3. d.c. and low frequency.

4. Duration 10 seconds maximum at a distance of not less than 2.0mm from the device body and the same lead shall not be resoldered until 3 minutes have elapsed.

FIGURE 1 - PARAMETER DERATING INFORMATION



Rated Voltage versus Temperature

NOTES

- 1. See U_{R1} Voltage value for each variant on Table 1(a), Column 2(a).
- 2. See U_{B2} Voltage value for each variant on Table 1(a), Column 2(b).

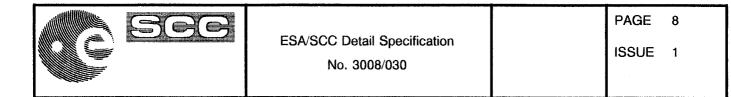
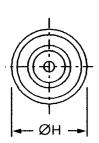
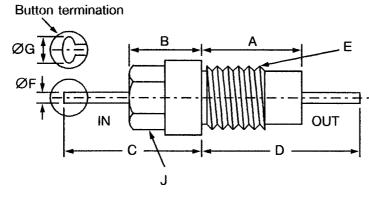
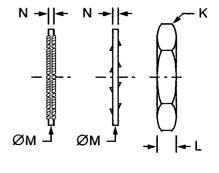


FIGURE 2 - PHYSICAL DIMENSIONS

FIGURE 2(a) - CASE SIZE 1

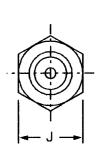


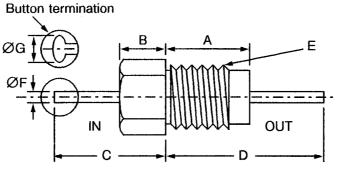




Fan Tooth

FIGURE 2(b) - CASE SIZE 2





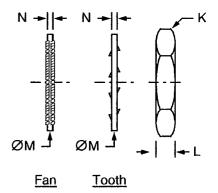
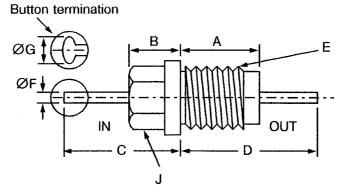


FIGURE 2(c) - CASE SIZE 3





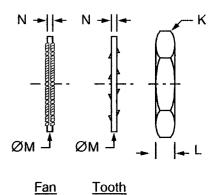




FIGURE 2 - PHYSICAL DIMENSIONS (CONTINUED)

	Case	Size 1	Case	Case Size 2		Size 3	
Symbol	Millim	Millimetres Millimetres Millim		etres	Notes		
	Min.	Max.	Min.	Max.	Min.	Max.	
A	10.40	10.60	6.90	7.10	7.90	8.10	
В	6.90	7.10	4.90	5.10	3.90	4.10	
С	-	12.00	-	10.00	-	9.00	1, 2
D	-	20.00	-	20.00	-	23.00	1, 2
E	See Tal	ole 1(a)	See Ta	ole 1(a)	See Ta	ble 1(a)	Thread
ØF	0.72	0.88	0.72	0.88	0.72	0.88	
ØG	1.00	1.20	1.00	1.20	1.00	1.20	3
ØН	6.90	7.10	-	-	6.90	7.10	
J	4.90	5.00	5.90	6.00	4.90	5.00	
К	-	8.00	-	8.00	-	8.00	Variants 01 to 14
	-	7.00	-	7.00	-	7.00	Variants 15 to 28
L	-	2.50	-	2.50	-	2.50	Variants 01 to 14
	-	3.00	-	3.00	-	3.00	Variants 15 to 28
ØМ	-	9.40	-	9.40	-	9.40	Variants 01 to 14
	-	10.20	-	10.20	-	10.20	Variants 15 to 28
N	-	0.40	-	0.40	-	0.40	Variants 01 to 14
	-	0.60	-	0.60	-	0.60	Variants 15 to 28

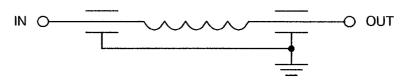
NOTES

1. Lead finish shall commence not more than 1.5mm from encapsulant.

2. The terminals are defined as rigid.

3. Applicable only to Variants 08 to 14 and 22 to 28.

FIGURE 3 - FUNCTIONAL DIAGRAM





4. **REQUIREMENTS**

4.1 <u>GENERAL</u>

The complete requirements for procurement of the components specified herein are stated in this specification and ESA/SCC Generic Specification No. 3008 for Capacitors and Capacitor Filters, Feedthrough. Deviations from the Generic Specification, applicable to this specification only, are detailed in Para. 4.2.

Deviations from the applicable Generic Specification and this Detail Specification, formally agreed with specific Manufacturers on the basis that the alternative requirements are equivalent to the ESA/SCC requirements and do not affect the components' reliability, are listed in the appendices attached to this specification.

4.2 DEVIATIONS FROM GENERIC SPECIFICATION

- 4.2.1 <u>Deviations from Special In-process Controls</u> None.
- 4.2.2 Deviations from Final Production Tests (Chart II)
 - (a) Para. 9.7, External Visual Inspection: For variants with a silver plated case, a change of shade is acceptable.
- 4.2.3 Deviations from Burn-in and Electrical Measurements (Chart III)
 - (a) Para. 9.7, External Visual Inspection: For variants with a silver plated case, a change of shade is acceptable.
- 4.2.4 Deviations from Qualification Tests (Chart IV)
 - (a) Para. 9.7, External Visual Inspection: For variants with a silver plated case, a change of shade is acceptable.
 - (b) Para. 9.12, Accelerated Damp Heat: Shall not be performed.
 - (c) Para. 9.15, Immersion: Shall not be performed.

4.2.5 Deviations from Lot Acceptance Tests (Chart V)

- (a) Para. 9.7, External Visual Inspection: For variants with a silver plated case, a change of shade is acceptable.
- (b) Para. 9.15, Immersion: Shall not be performed.

4.3 MECHANICAL REQUIREMENTS

4.3.1 Dimension Check

The dimensions of the components specified herein shall be verified in accordance with the requirements set out in Para. 9.5 of ESA/SCC Generic Specification No. 3008 and they shall conform to those shown in Figure 2 of this specification.

4.3.2 Weight

The maximum weight of the components specified herein shall be as given in Table 1(a).



4.3.3 Robustness of Terminations

The requirements for the robustness of terminations tests are specified in Section 9 of ESA/SCC Generic Specification No. 3008. The leads are defined as "Rigid".

Test Ua1, Tensile: The load shall be 10N.

4.3.4 Solderability

The requirements for solderability testing are specified in Section 9 of ESA/SCC Generic Specification No. 3008.

Test Method 1 shall apply and a thermal screen of 1.6mm may be used. The terminal shall be immersed up to 2.0mm from the body.

4.3.5 <u>Seal Test</u>

Not applicable.

4.4 MATERIALS AND FINISHES

The materials and finishes shall be as specified herein. Where a definite material is not specified, a material which will enable the components specified herein to meet the performance requirements of this specification shall be used. Acceptance or approval of any constituent material does not guarantee acceptance of the finished product.

4.4.1 <u>Case</u>

The case shall be silver plated brass with resin sealing the filter element.

4.4.2 Lead Material and Finish

The lead material shall be Type 'A' with Type '10' finish in accordance with the requirements of ESA/SCC Basic Specification No. 23500.

4.4.3 Accessories

Nut : As per Figure 2, brass, silver-plated.

Lock-Washer : As per Figure 2, bronze, silver-plated.

4.5 MARKING

4.5.1 <u>General</u>

The marking of components delivered to this specification shall be in accordance with the requirements of ESA/SCC Basic Specification No. 21700 and the following paragraphs. When the component is too small to accommodate all of the marking specified, as much as space permits shall be marked and the marking information, in full, shall accompany the component in its primary package.

The information to be marked and the order of precedence, shall be as follows:-

- (a) Lead Identification.
- (b) The SCC Component Number.
- (c) Traceability Information.

300803001B

4.5.2 Lead Identification

Not applicable.

SIC

4.5.3 The SCC Component Number

The SCC Component Number shall be constituted and marked as follows:-

Detail Specification Number

Type Variant (see Table 1(a))

Testing Level (B or C, as applicable) ------

4.5.4 <u>Traceability Information</u>

Each component shall be marked in respect of traceability information in accordance with the requirements of ESA/SCC Basic Specification No. 21700.

4.6 ELECTRICAL MEASUREMENTS

4.6.1 Electrical Measurements at Room Temperature

The parameters to be measured at room temperature are scheduled in Table 2. Unless otherwise specified, measurements shall be performed at T_{amb} = +22 ± 3 °C.

4.6.2 Electrical Measurements at High and Low Temperatures

The parameters to be measured at high and low temperatures are scheduled in Table 3. Measurements shall be performed at $T_{amb} = 125(+0-5)$ °C and -55(+5-0) °C respectively.

4.6.3 <u>Circuits for Electrical Measurements (Figure 4)</u>

Not applicable.

4.7 BURN-IN TESTS

4.7.1 Parameter Drift Values

The parameter drift values applicable to burn-in are as specified in Table 4 of this specification. Unless otherwise stated, measurements shall be performed at $T_{amb} = +22 \pm 3$ °C. The parameter drift values (Δ) applicable to the parameters scheduled shall not be exceeded. In addition to these drift value requirements for a given parameter, the appropriate limit values specified in Table 2 shall not be exceeded.

4.7.2 <u>Conditions for Burn-in</u>

The requirements for burn-in are specified in Section 7 of ESA/SCC Generic Specification No. 3008. The conditions for burn-in shall be as specified in Table 5(a) of this specification.

4.7.3 Electrical Circuit for Burn-in (Figure 5)

Not applicable.



TABLE 2 - ELECTRICAL MEASUREMENTS AT ROOM TEMPERATURE - d.c. PARAMETERS

No.	Characteristics	Symbol	ESA/SCC 3008	Test	Lin	Lloit	
No. Characteristics Symbol	Test Method	Conditions	Min	Max	Unit		
1	Voltage Drop	V _{dr}	Para. 9.4.1.5	I _R = 10A	-	Note 1	V
2	Voltage Proof	VP	Para. 9.4.1.2		Note 2	-	V
3	Insulation Resistance	Ri	Para. 9.4.1.3	Para. 9.4.1.3	Note 3	-	MΩ

NOTES

- 1. See Column 5 of Table 1(a).
- 2. See Column 4 of Table 1(a).
- 3. See Column 3(a) of Table 1(a).

TABLE 2 - ELECTRICAL MEASUREMENTS AT ROOM TEMPERATURE - a.c. PARAMETERS

No.	Characteristics	Symbol	ESA/SCC 3008 Test Method	Test Conditions	Lin	Unit	
NO.	Characteristics	Зуший			Min	Max	Unit
4	Insertion Loss	IL1	Para. 9.4.1.4	f = 10MHz Note 1	Note 2	-	dB
5	Insertion Loss	I _{L2}	Para. 9.4.1.4	f = 50MHz Note 3	Note 2	-	dB
6	Insertion Loss	I _{L3}	Para. 9.4.1.4	f = 100MHz Note 1	Note 2	-	dB
7	Insertion Loss	IL4	Para. 9.4.1.4	f = 500MHz Note 1	Note 2	-	dB
8	Insertion Loss	I _{L5}	Para. 9.4.1.4	f = 1.0GHz Note 1	Note 2	-	dB
9	Capacitance	С	Para. 9.4.1.1	Para. 9.4.1.1	Note 4	-	pF

NOTES

- 1. Measurements at rated current to be made only during Chart IV testing in Subgroups II or III. Measurements without load current to be made during Charts II, III and V.
- 2. See Column 9 of Table 1(a).
- 3. Measurements at this frequency to be made only during Chart IV testing.
- 4. See Column 8 of Table 1(a).



TABLE 3 - ELECTRICAL MEASUREMENTS AT HIGH AND LOW TEMPERATURES

No.	Characteristics	Symbol	ESA/SCC 3008 Test Method	Test Conditions	Lin	Unit	
110.	Characteristics			(Note 1)	Min	Max	Unit
3	Insulation Resistance	Ri	Para. 9.4.1.3	Para. 9.4.1.3 Note 2	Note 3	-	MΩ
4	Insertion Loss	I _{L1}	Para. 9.4.1.4	f = 10MHz No current.	Note 4	-	dB
6	Insertion Loss	I _{L3}	Para. 9.4.1.4	f = 100MHz No current.	Note 4	-	dB
8	Insertion Loss	I _{L5}	Para. 9.4.1.4	f = 1.0GHz No current.	Note 4	-	dB

NOTES

1. If more than 20 units have to be measured, the measurement shall be performed on a sample basis in accordance with Inspection Level I, Table IIA, AQL = 1.0% of IEC Publication No. 410.

2. Insulation resistance is to be performed only at high temperature.

3. See Column 3(b) of Table 1(a).

4. See Column 9 of Table 1(a).



FIGURE 4 - CIRCUITS FOR ELECTRICAL MEASUREMENTS

Not applicable.

TABLE 4 - PARAMETER DRIFT VALUES

No.	Characteristics	Symbol	Spec. and/or Test Method	Test Conditions	Change Limits (Δ)	Unit
9	Capacitance Change	Δ <u>C</u> C	As per Table 2	As per Table 2	± 10	%

TABLE 5(a) - CONDITIONS FOR BURN-IN TESTS

No.	Characteristic	Symbol	Condition	Unit
1	Ambient Temperature	T _{amb}	+ 125(+ 0 - 3)	°C
2	Test Voltage	V _T	2×U _R at +125°C Note 1	V

<u>NOTES</u>

1. Applied between one terminal and the case. See Column 2(b) of Table 1(a) for value of U_R.

TABLE 5(b) - CONDITIONS FOR OPERATING LIFE TESTS

No.	Characteristic	Symbol	ol Condition	
1	Ambient Temperature	T _{amb}	+ 125(+ 0 - 3)	°C
2	Test Voltage	V _T	2×U _R at +125°C Note 1	V
3	Rated Current	IR	10 Note 2	A

NOTES

- 1. Applied between one terminal and the case. See Column 2(b) of Table 1(a) for value of U_R.
- 2. To flow between the terminals.

FIGURE 5 - ELECTRICAL CIRCUIT FOR BURN-IN AND OPERATING LIFE TESTS

Not applicable.



4.8 <u>ENVIRONMENTAL AND ENDURANCE TESTS (CHARTS IV AND V OF ESA/SCC GENERIC</u> <u>SPECIFICATION No. 3008)</u>

4.8.1 <u>Measurements and Inspections on Completion of Environmental Tests</u>

The parameters to be measured and inspections to be performed on completion of environmental tests are scheduled in Table 6. Unless otherwise stated, the measurements shall be performed at $T_{amb} = +22 \pm 3$ °C.

4.8.2 Measurements and Inspections at Intermediate Points During Endurance Tests

The parameters to be measured and inspections to be performed at intermediate points during endurance tests are scheduled in Table 6. Unless otherwise stated, the measurements shall be performed at T_{amb} = +22 ±3 °C.

4.8.3 Measurements and Inspections on Completion of Endurance Tests

The parameters to be measured and inspections to be performed on completion of endurance testing are as scheduled in Table 6. Unless otherwise stated, the measurements shall be performed at T_{amb} = +22 ± 3 °C.

4.8.4 Conditions for Operating Life Tests (Part of Endurance Testing)

The requirements for operating life test are specified in Section 9 of ESA/SCC Generic Specification No. 3008. The conditions for operating life testing shall be as specified in Table 5(b) of this specification.

4.8.5 Electrical Circuit for Operating Life Tests (Figure 5)

Not applicable.



TABLE 6 - MEASUREMENTS AND INSPECTIONS ON COMPLETION OF ENVIRONMENTAL TESTS AND AT INTERMEDIATE POINTS AND ON COMPLETION OF ENDURANCE TESTING

	ESA/SCC GENERIC S	SPEC. NO. 3008	MEASUREMENTS	AND INSPECTIONS		LIMI	тѕ	
NO.	ENVIRONMENTAL AND ENDURANCE TESTS (1)	TEST METHOD AND CONDITIONS	IDENTIFICATION	CONDITIONS	Symbol	MIN.	MAX.	UNIT
01	Seal Test (Hermetically Sealed)	Para. 9.6	Not applicable					
02	External Visual Inspection	Para. 9.7 and Paras 4.2.4 and 4.2.5 of this spec.	Final Measurements Visual Inspection	ESA/SCC No. 20500	-	-	-	
03	Temperature Rise	Para. 9.9	Temperature Rise	Rated Current (3)	-	-	25	°C
04	Shock	Para. 9.10	Measurements during Tests Final Measurements	100% U _R (2) applied No Open or Short Circuits >0.1ms		-	-	
			Visual Examination Insertion Loss	No Mechanical Damage Table 2 Items 4 to 8	- - - IL	- Table 2	-	
05	Vibration	Para. 9.11	Measurements during Tests During Last Cycle	Rated Current (3) and 100% U _R (2) applied No Open or Short Circuits >0.1ms	-	-	-	
			Final Measurements Visual Examination Insertion Loss	No Mechanical Damage Table 2 Items 4 to 8	۔ ار	Table 2	-	
06	Accelerated Damp Heat	Para. 9.12 and Para. 4.2.4 of this spec.	Not applicable					
07	Low Air Pressure	Para. 9.13	Measurements during Tests Voltage Proof	During last 5 minutes Table 2 Item 2	VP	125% U _R (2)		
			Visual Examination	No breakdown, flashover, deformation or seepage	-	-	-	
			Final Measurements Visual Examination	No breakdown, flashover, deformation or seepage	-	-	-	
08	Robustness of Terminations	Para. 9.14 and Para. 4.3.3 of this spec.	Final Measurements Visual Examination Voltage Drop	No damage Table 2 Item 1	- V _{dr}	-	- Table 2	
09	Immersion	Para. 9.15 and Paras 4.2.4 and 4.2.5 of this spec.	Not applicable					
10	Overload	Para. 9.16	Final Measurements	140% of Rated Current (3) for 15 mins min.				
			Insulation Resistance Voltage Drop Visual Examination	Table 2 Item 3 Table 2 Item 1 No damage	Ri V _{dr}	Table 2 - -	Table 2	

NOTES

- 1. The tests in this Table refer to either Chart IV or V and shall be used as applicable. 2. For U_R , see Column 2(a) of Table 1(a).
- 3. For I_R , see Column 7 of Table 1(a).
- 4. Greater than 50% of the value given in Table 2.
- 5. Greater than 10% of the value given in Table 2.



TABLE 6 - MEASUREMENTS AND INSPECTIONS ON COMPLETION OF ENVIRONMENTAL TESTS AND AT INTERMEDIATE POINTS AND ON COMPLETION OF ENDURANCE TESTING (CONT'D)

ESA/SCC GENERIC SPEC. NO. 3008		MEASUREMENTS	AND INSPECTIONS		LIMITS		
ENVIRONMENTAL AND ENDURANCE TESTS (1)	TEST METHOD AND CONDITIONS	IDENTIFICATION	CONDITIONS	SYMBOL	MIN.	MAX.	UNIT
Resistance to Soldering Heat	Para. 9.17	Final Measurements Visual Examination Insulation Resistance Insertion Loss	After recovery of 1 to 2 hrs No damage Table 2 Item 3 Table 2 Items 4 to 8	- Ri I _L	Table 2 Table 2	-	
Solderability	Para. 9.18 and Para. 4.3.4 of this spec.	Final Measurements Visual Examination	IEC No. 68-2-20 Para. 4.6.4, 4.7.4 or 4.9.3	-	-	-	
Operating Life	Para. 9.19	Initial Measurements Capacitance During Tests Intermediate Measurements	Table 2 Item 9 No Open or Short Circuit	C -	Record -	values -	
		Insulation Resistance Voltage Proof	Table 3 Item 3 After 24 hrs recovery Table 2 Item 2	Ri VP	Table 3 90% U _R (2)	-	
		Insulation Resistance Insertion Loss Capacitance Change Final Measurements	Table 2 Item 3 Table 2 Items 4 to 8 Table 2 Item 9	Ri I∟ ∆C/C	(4) Table 2	Table 4	
		Voltage Proof	After 24 hrs recovery Table 2 Item 2	VP	90% U _R	-	
		Insulation Resistance Insertion Loss Capacitance Change	Table 2 Item 3 Table 2 Items 4 to 8 Table 2 Item 9	Ri I _L ∆C/C	(4) Table 2	Table 4	
Corrosion	Para. 9.20	Final Measurements Visual Examination	No corrosion, damage or obliteration of marking	-	-	-	
Permanence of Marking	Para. 9.21	Final Measurements Visual Examination	No corrosion or obliteration of marking	-	-	-	
Damp Heat (Non-hermetically Sealed)	Para. 9.24	Final Measurements Visual Examination	After 4 hrs recovery No cracking or encapsulant separation Table 2 tom 2	- Di	-	-	
	ENVIRONMENTAL AND ENDURANCE TESTS (1) Resistance to Soldering Heat Solderability Operating Life Corrosion Permanence of Marking Damp Heat	ENVIRONMENTAL AND ENDURANCE TESTS (1)TEST METHOD AND CONDITIONSResistance to Soldering HeatPara. 9.17SolderabilityPara. 9.18 and Para. 4.3.4 of this spec.Operating LifePara. 9.19Operating LifePara. 9.19CorrosionPara. 9.20Permanence of MarkingPara. 9.21Damp HeatPara. 9.24	ENVIRONMENTAL AND ENDURANCE TESTS (1)TEST METHOD AND CONDITIONSIDENTIFICATIONResistance to Soldering HeatPara. 9.17Final Measurements Visual Examination Insulation Resistance Insulation Resistance Insulation Resistance Insulation Resistance Deration LossFinal Measurements Visual ExaminationSolderabilityPara. 9.18 and Para. 4.3.4 of this spec.Final Measurements Visual ExaminationOperating LifePara. 9.19Initial Measurements Capacitance During Tests Intermediate Measurements Insulation Resistance Voltage Proof Insulation Resistance Voltage ProofCorrosionPara. 9.20Final Measurements Visual ExaminationPermanence of MarkingPara. 9.21Final Measurements Visual ExaminationDamp HeatPara. 9.24Final Measurements Para 9.24	ENVIRONMENTAL AND ENDURANCE TESTS (1)TEST METHOD AND CONDITIONSIDENTIFICATIONCONDITIONSResistance to Soldering HeatPara. 9.17Final Measurements Visual Examination Insulation Resistance Insertion LossAfter recovery of 1 to 2 hrs No damage Table 2 item 3 Table 2 item 3 Table 2 item 3SolderabilityPara. 9.18 and Para. 4.3.4 of this spec.Final Measurements Visual Examination Insulation Resistance Insertion LossIEC No. 68-2-20 Para. 4.6.4.7.4 or 4.9.3Operating LifePara. 9.19Initial Measurements Capacitance Insulation Resistance Insulation Resistance Insulation Resistance Insulation Resistance Insulation Resistance Insulation Resistance Insulation Resistance Insulation Resistance Table 2 item 3 Table 2 item 3 Table 2 item 3 Table 2 item 4 to 8 Table 2 item 3 Table 2 item 3 Table 2 item 4 to 8 Table 2 item 3 Table 2 item 3 Table 2 item 3 Table 2 item 4 to 8 Table 2 item 3 Table 2 item 3 Table 2 item 3 Table 2 item 3 Table 2 item 4 to 8 Table 2 item 4 to 8 Table 2 item 4 to 8 Table 2 item 3 Table 2 item 4 to 8 Table 2 item 3 Table 2 item 4 to 8 Table 2 item 4 to 8 T	ENVIRONMENTAL AND ENDURANCE TESTS (1)TEST METHOD AND CONDITIONSIDENTIFICATIONCONDITIONSSYMBOLResistance to Soldering HeatPara. 9.17Final Measurements Insulation Resistance Insertion LossAfter recovery of 1 to 2 hrs No damage Table 2 ltems 4 to 8-SolderabilityPara. 9.18 and Para. 4.3.4 of this spec.Final Measurements Visual Examination Insulation Resistance During TestsIEC No. 68-2-20 Para. 4.6.4, 4.7.4 or 4.9.3-Operating LifePara. 9.19Initial Measurements Capacitance During Tests Intermediate Measurements Insulation Resistance Insulation Resistance Insulation Resistance Insulation Resistance Capacitance Change Final Measurements Insulation Resistance Insulation Resistanc	EnvireOnmental AND ENDURANCE TESTS (1)TEST METHOD AND CONDITIONSIDENTIFICATIONCONDITIONSSYMBOLMIN.Resistance to Soldering HeatPara. 9.17Final Measurements visual Examination Insulation Resistance Insertion LossAfter recovery of 1 to 2 hrs No damage Table 2 tiems 4 to 8- - - Table 2- - - Table 2SolderabilityPara. 9.18 and Para. 4.3.4 of this spec.Final Measurements Visual Examination Interimediate Capacitance During TestsEC No. 68-2-20 Para. 4.6.4, 4.7.4 or 4.9.3- - - Operating LifePara. 9.19Initial Measurements Capacitance During TestsTable 2 litem 9 No Open or Short CircuitC - - - -Ri (4) Table 2 litem 2Operating LifePara. 9.19Initial Measurements Capacitance During TestsTable 2 litem 9 No Open or Short CircuitC - - - -Ri (4) Table 2 litem 2Operating LifePara. 9.20Final Measurements Insulation Resistance Insulation ResistanceRi Table 2 litem 3 Ri <b< td=""><td>ENVIRONMENTAL AND ENDURANCE TESTS (1) TEST METHOD AND CONDITIONS IDENTIFICATION CONDITIONS SYMBOL MAX. Resistance to Soldering Heat Para. 9.17 Final Measurements insulation Resistance Insulation Loss Alter recovery of 1 to 2 tris No damage Table 2 tiem 3 rable 2 tiem 9 No Open or Short Create insertion Loss Intermediate Measurements rable 2 tiem 9 No Open or Short Create insertion Loss C Record values rable 2 rable 2 tiem 9 No Open or Short Create insertion Loss Ri rable 3 tiem 3 rable 2 tiem 9 No Open or Short Create there shore short Create rable 2 tiem 3 rable 2 tiem 4 to 8 rable 2 tiem 4 rable 2 tiem 4 rable 2 tiem 5 rable 2 tiem 3 rable 2 tiem 3 rable 2 tiem 3 rable 2 tiem 3 rable 2 tiem 4 rable 2 tiem 4 rable 2 tiem 4 rable 2 tiem 5 rable 2 tiem 5 rable 2 tiem 5 rable 2 tiem 4 rable 2 tiem 5 rable 2 tiem 4 rable 2 tiem 5 rable 2 tiem</td></b<>	ENVIRONMENTAL AND ENDURANCE TESTS (1) TEST METHOD AND CONDITIONS IDENTIFICATION CONDITIONS SYMBOL MAX. Resistance to Soldering Heat Para. 9.17 Final Measurements insulation Resistance Insulation Loss Alter recovery of 1 to 2 tris No damage Table 2 tiem 3 rable 2 tiem 9 No Open or Short Create insertion Loss Intermediate Measurements rable 2 tiem 9 No Open or Short Create insertion Loss C Record values rable 2 rable 2 tiem 9 No Open or Short Create insertion Loss Ri rable 3 tiem 3 rable 2 tiem 9 No Open or Short Create there shore short Create rable 2 tiem 3 rable 2 tiem 4 to 8 rable 2 tiem 4 rable 2 tiem 4 rable 2 tiem 5 rable 2 tiem 3 rable 2 tiem 3 rable 2 tiem 3 rable 2 tiem 3 rable 2 tiem 4 rable 2 tiem 4 rable 2 tiem 4 rable 2 tiem 5 rable 2 tiem 5 rable 2 tiem 5 rable 2 tiem 4 rable 2 tiem 5 rable 2 tiem 4 rable 2 tiem 5 rable 2 tiem

NOTES: See Page 17.



APPENDIX 'A'

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AGREED DEVIATIONS FOR EUROFARAD (F)

ITEMS AFFECTED	DESCRIPTION OF DEVIATIONS
Paras. 4.2.2 and 4.2.3	(a) Para. 9.4.1.5, Voltage Drop: Voltage Drop may be performed as a d.c. Resistance measurement in accordance with MIL-STD-202, Method 303. In this case, the maximum value of d.c. Resistance (Rs) shall be as specified in Column 6 of Table 1(a).